



# **General Description**

The WST6066A is the highest performance trench N-ch MOSFETs with extreme high cell density , which provide excellent  $R_{\rm DSON}$  and gate charge for most of the synchronous buck converter applications .

The WST6066A meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

#### **Features**

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

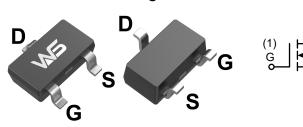
# **Product Summery**

BV <sub>DSS</sub>	R <sub>DSON</sub>	I <sub>D</sub>
60V	85mΩ	2.1A

# **Applications**

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

# **SOT-23-3L Pin Configuration**



# **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	60	V
$V_{GS}$	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25℃	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	2.1	Α
I <sub>D</sub> @T <sub>C</sub> =70°C	I <sub>D</sub> @T <sub>C</sub> =70℃ Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>		Α
I <sub>DM</sub>	I <sub>DM</sub> Pulsed Drain Current <sup>2</sup>		Α
EAS	Single Pulse Avalanche Energy <sup>3</sup>	15	mJ
I <sub>AS</sub>	I <sub>AS</sub> Avalanche Current		Α
P <sub>D</sub> @T <sub>A</sub> =25°C	P <sub>D</sub> @T <sub>A</sub> =25℃ Total Power Dissipation <sup>4</sup>		W
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	${\mathbb C}$
$T_J$	T <sub>J</sub> Operating Junction Temperature Range		$^{\circ}$

#### **Thermal Data**

Symbol	Parameter		Max.	Unit
R <sub>0JA</sub>	Thermal Resistance Junction-ambient <sup>1</sup>		125	°C/W
R <sub>0JC</sub>	Thermal Resistance Junction-Case <sup>1</sup>		25	°C/W



N-Ch MOSFET

# Electrical Characteristics (T<sub>J</sub>=25 ℃, unless otherwise noted)

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	60			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.041		V/°C	
В	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =2.1A		85	110	0	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =2.5V , I <sub>D</sub> =1.5A		95	120	mΩ	
V <sub>GS(th)</sub>	Gate Threshold Voltage	\/ -\/   -250\	1.0	1.5	2.5	V	
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D=250uA$		-4.7		mV/℃	
	Drain Source Leakage Current	V <sub>DS</sub> =44V , V <sub>GS</sub> =0V , T <sub>J</sub> =25℃			1		
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =44V , V <sub>GS</sub> =0V , T <sub>J</sub> =85°C			5	uA	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ = $\pm 20 V$ , $V_{DS}$ = $0 V$			±100	nA	
gfs	gfs Forward Transconductance V <sub>DS</sub> =5V , I <sub>D</sub> =4A			10		S	
$R_g$	R <sub>g</sub> Gate Resistance V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz			2.5	5	Ω	
$Q_{g}$	Total Gate Charge (10V)			2.1	3.9		
$Q_{gs}$	Gate-Source Charge	$V_{DS}$ =27V , $V_{GS}$ =4.5V , $I_{D}$ =2.1A		0.6		nC	
Q <sub>gd</sub>	Gate-Drain Charge			0.8			
$T_{d(on)}$	Turn-On Delay Time			3.5			
T <sub>r</sub>	Rise Time	$V_{DD}$ =27V , $V_{GS}$ =10V , $R_{G}$ =6 $\Omega$		3.6			
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =1A		3		ns	
T <sub>f</sub>	Fall Time			32			
Ciss	Input Capacitance			295			
C <sub>oss</sub> Output Capacitance		V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz		40		pF	
C <sub>rss</sub>	C <sub>rss</sub> Reverse Transfer Capacitance			15			

### **Guaranteed Avalanche Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy <sup>5</sup>	V <sub>DD</sub> =25V , L=0.1mH , I <sub>AS</sub> =15A	15.2			mJ

# **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current <sup>1,6</sup>	V =V =0V Force Current			1	Α
I <sub>SM</sub>	Pulsed Source Current <sup>2,6</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			4	Α
V <sub>SD</sub>	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25℃			1.2	V
t <sub>rr</sub>	Reverse Recovery Time			10.1		nS
Q <sub>rr</sub>	Reverse Recovery Charge	l⊧=4A , dl/dt=100A/μs , T <sub>J</sub> =25℃		6.4		nC

#### Note:

- 1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width  $\,\leq\,$  300us , duty cycle  $\,\leq\,$  2%
- 3. The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V,  $V_{GS}$ =10V, L=0.1mH,  $I_{AS}$ =15A
- 4.The power dissipation is limited by 150 °C junction temperature
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as  $I_D$  and  $I_{DM}$ , in real applications, should be limited by total power dissipation.



# TYPICAL CHARACTERISTICS (25 °C Unless Note)

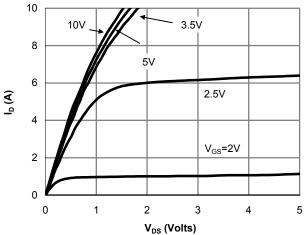


Fig 1: On-Region characteristics

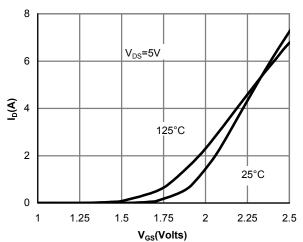


Figure 2: Transfer Characteristics

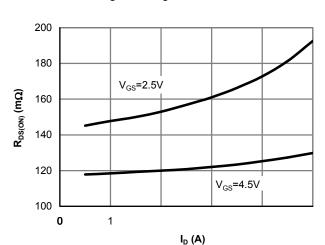


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

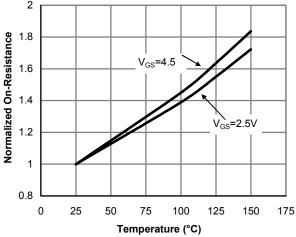


Figure 4: On-Resistance vs. Junction Temperature

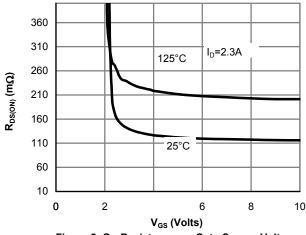


Figure 5: On-Resistance vs. Gate-Source Voltage

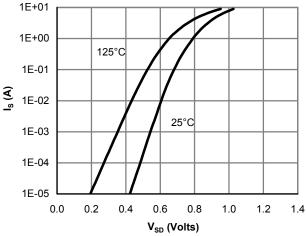


Figure 6: Body-Diode Characteristics



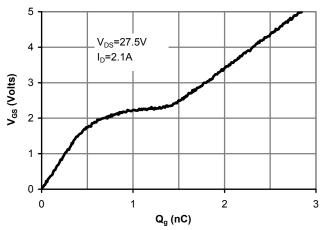


Figure 7: Gate-Charge Characteristics

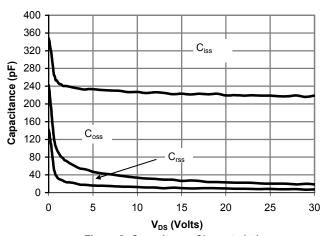


Figure 8: Capacitance Characteristics

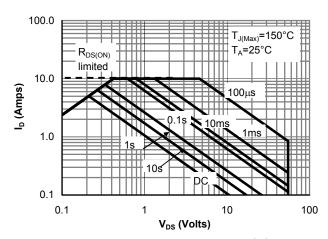


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

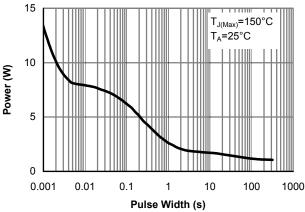


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

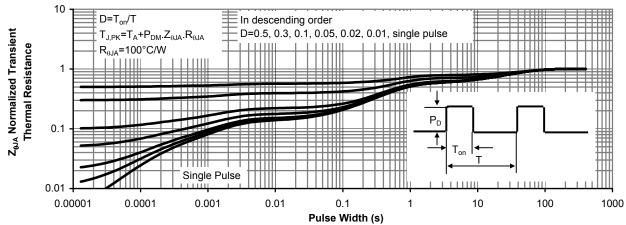
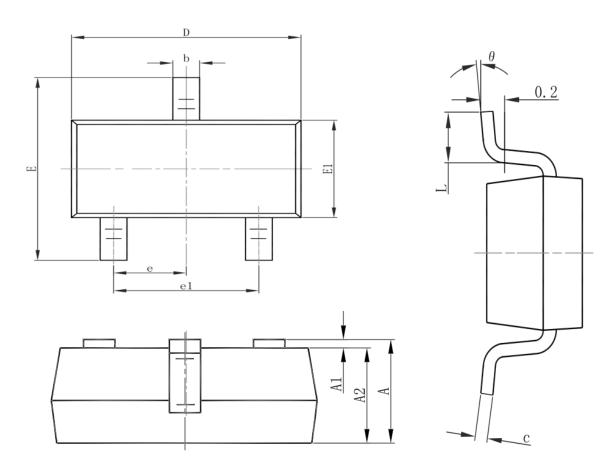


Figure 11: Normalized Maximum Transient Thermal Impedance



# **Packaging information**



Consolo al	Dimensions In Millimeters		Dimensio	ns In Inches
Symbol	Min.	Max.	Min.	Max.
Α	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
С	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E1	1.500	1.700	0.059	0.067
E	2.650	2.950	0.104	0.116
е	0.950	(BSC)	0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°



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